

Notice of References Cited	Application/Control No. 10/659,055		Applicant(s)/Patent Under Reexamination AERTGEERTS ET AL.	
	Examiner Nashaat T. Nashed, Ph. D.		Art Unit 1656	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0260732	11-2005	Hiramatsu et al.	435/226
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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